

## Machine Intelligence 1 2.1 Elements of Statistical Learning Theory

Prof. Dr. Klaus Obermayer

Fachgebiet Neuronale Informationsverarbeitung (NI)

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## Background

#### Central question

What must one know a priori about an unknown functional dependency in order to estimate it on the basis of observations? (Vapnik 1995)

- Regularization principles for solving ill-posed problems (e.g. Tikhonov)
- Nonparametric statistics (e.g. Parzen)
- Law of large numbers in functional space (Vapnik & Chervonenkis)
- Algorithmic complexity (Kolmogorov, Solomonoff, Chaitin)

## Empirical Risk Minimization (ERM)

$$E^G_{[\underline{\mathbf{w}}]} = \int P_{(y_T,\underline{\mathbf{x}})} \, e_{(y_T,\underline{\mathbf{x}};\underline{\mathbf{w}})} \, d\underline{\mathbf{x}} \, dy_T \stackrel{!}{=} \min \quad \text{(generalization error)}$$

mathematical expectation

$$\Downarrow$$
 ERM  $\Downarrow$   $\leftarrow$  When does this work? empirical average

$$E_{[\underline{\mathbf{w}}]}^T = \frac{1}{p} \sum_{\alpha=1}^p e_{(y_T^{(\alpha)}, \underline{\mathbf{x}}^{(\alpha)}; \underline{\mathbf{w}})} \stackrel{!}{=} \min$$
 (training error)

## The law of large numbers

"The sequence of means converges to the expectation of a random variable (if it exists) as the number p of samples increases."

- can only be applied if set of predictors has a finite number of elements (use Hoeffding's inequality for bound on deviations)
- extension to infinite sets (e.g. MLPs) necessary

## Statistical learning theory (SLT)

Goal: Estimate a desired function from

- a wide set of functions
- a limited number of examples

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#### Achievements of statistical learning theory

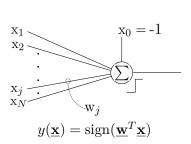
- formulation of conditions under which ERM works
- bounds describing generalization ability of ERM
- 3 inductive inference for small sample sizes based on these bounds
- $oldsymbol{0}$  methods for implementing this new type of inference  $( o { t SVMs})$

## 2.1.1 Linear Classifiers: An Example

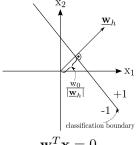
#### Linear classifiers

- data representation: samples  $\underline{\mathbf{x}}^{(\alpha)} \in \mathbb{R}^N$  and classes  $y_T^{(\alpha)} \in \{-1,1\}$
- model class: binary connectionist neuron

binary connectionist neuron



classification boundary



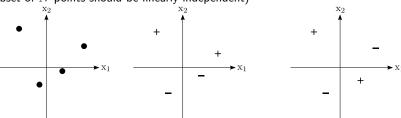
$$\mathbf{\underline{w}}^T \mathbf{\underline{x}} = 0$$

## Optimization with ERM

- performance measure: classification error
- optimization: minimizing the training error (ERM)
  - which conditions yield small training errors?
- validation: evaluate test error on unseen data
  - which conditions yield small generalization errors?

## Linear separability

- $\sim$  classes do not overlap  $\sim$  classes can be separated by a hyperplane
- all data points can be correctly classified by at least one classifier from the set
- observations  $\underline{\mathbf{x}}^{(\alpha)} \in \mathbb{R}^N, \alpha = 1, \dots, p$ , in general location ( $\rightarrow$  each subset of N points should be linearly independent)



in general location separable assignment ass. not linearly separable

■ 14 linearly separable configurations, 2 configurations not separable

## Statistics of linear separability (Cover, 1965)

(1) **number**  $C_{(p,N)}$  of linearly separable assignments  $y_T : \underline{\mathbf{x}} \to y_T$ :

$$C_{(p,N)} = 2\sum_{k=0}^{N-1} \binom{p-1}{k}$$

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(2) **fraction**  $\Pi_{(p,N)}$  of linearly separable assignments (total:  $2^p$ ):

$$\Pi_{(p,N)} = \frac{C_{(p,N)}}{2^p} = \frac{1}{2^{p-1}} \sum_{k=0}^{N-1} \binom{p-1}{k}$$

### Asymptotic distribution

$$\Pi_{(p,N)} = \sum_{k=0}^{N-1} \overbrace{\binom{p-1}{k} \left(\frac{1}{2}\right)^k \left(\frac{1}{2}\right)^{p-1-k}}^{f(k \mid p-1,\frac{1}{2})}$$

$$f(k \mid n,q) = \binom{n}{k} q^k (1-q)^{n-k} \qquad \text{(Binomial distribution)}$$

 $\blacksquare$   $\Pi_{(p,N)}$  is the CDF of the Binomial distribution  $f(k \mid p-1, \frac{1}{2})$ 

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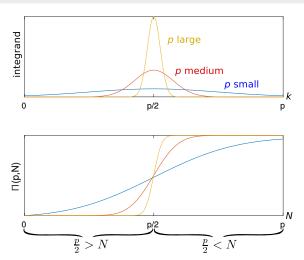
#### Binomial distribution converges to Gaussian distribution

$$f(k \,|\, n,q) \; pprox \; \mathcal{N} ig( k \,|\, nq, \, nq(1-q) ig)$$
 (asymptotic distribution)

In the limit  $N, p \to \infty$ , with  $\frac{p}{N} = \text{const}$ , one obtains:

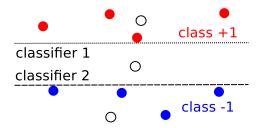
$$\Pi_{(p,N)} \quad \approx \quad \sum_{k=0}^{N-1} \mathcal{N}(k \mid \frac{p-1}{2}, \frac{p-1}{4}) \quad \underset{p \to \infty}{\approx} \quad \int_{-\infty}^{N} dk \, \exp\left(-\frac{1}{p/2}(k - \frac{p}{2})^2\right)$$

## Capacity of the set of linear classifiers

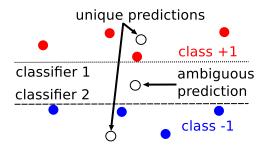


- $\blacksquare$  all  $2^p$  label configurations can be realized below  $\beta:=\frac{p}{N}=2$
- $\blacksquare$   $\beta$  can be understood as a natural capacity measure

## Generalization performance (1)



## Generalization performance (1)



■  $C_{(p,N-1)}$ : number of linearly separable assignments on p-1 data points, where there are still two choices left for the remaining data point (Cover, 1965).

## Generalization performance (2)

- fraction of ambiguous, linearly separable assignments

$$g_{(p,N)} := \frac{\text{\tiny ambiguous assignments}}{\text{\tiny all separable assignments}} = \frac{C_{(p,N-1)}}{C_{(p,N)}}$$

if fraction of ambiguous assignments is large, prediction for new data points will not be informative

## Generalization performance (2)

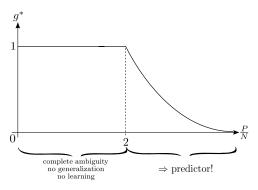
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$$g_{(p,N)} := \frac{\text{\tiny ambiguous assignments}}{\text{\tiny all separable assignments}} = \frac{C_{(p,N-1)}}{C_{(p,N)}}$$

- if fraction of ambiguous assignments is large, prediction for new data points will not be informative
- asymptotic result (Cover, 1965):

$$g^*_{(\frac{p}{N})} = \lim_{\substack{p,N \to \infty, \\ \frac{p}{N} = \mathrm{const}}} g_{(p,N)} = \left\{ \begin{array}{ll} 1, & \text{for } 0 \leq \frac{p}{N} \leq 2 \\ \\ \frac{1}{N} - 1, & \text{for } \frac{p}{N} > 2 \end{array} \right.$$

### How much data do we need to predict?



- for  $p/N \le 2$  almost all predictions are ambiguous.
- lacksquare for p/N>2 classifier is able to generalize to new data points

"The probability of ambiguous generalization is large unless the number of training patterns exceeds the capacity of the set of separating surfaces."

## The Vapnik-Chervonenkis (VC) dimension

#### key question of inductive reasoning

When will conclusions inferred from a sample of data be meaningful?

- → concept of non-falsifiability (Popper)
  - a theory is useful only, if it is falsifiable (cmp. astrology),
  - i.e. if it cannot predict all potentially observable patterns.

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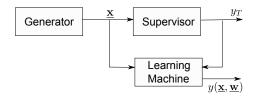
#### generalization of the capacity measure

VC-dimension  $\mathrm{d}_{\mathrm{VC}}$  describes the capacity of a family of functions  ${\mathcal{M}}$ 

- $\blacksquare \ d_{VC}$  is the largest number of samples in general locations...
  - lacksquare that can be classified by some  $f\in\mathcal{M}$  for any possible labeling
  - $\blacksquare$  that can be classified by some  $f\in\mathcal{M}$  without any empirical error

## 2.1.2 Formulation of the Inductive Learning Problem

## Inductive learning for binary classification



- lacktriangle generator draws  $\underline{\mathbf{x}} \in R^n$  from unknown  $P(\underline{\mathbf{x}})$
- supervisor returns output  $y_T \in \{-1, +1\}$  to every  $\underline{\mathbf{x}}$  from unknown  $P(y_T | \underline{\mathbf{x}})$
- learning machine estimates function  $y(\underline{\mathbf{x}},\underline{\mathbf{w}}) \approx y_T$ by selecting  $\underline{\mathbf{w}} \in \Lambda$  from the set of possible parameters  $\Lambda$
- performance is measured with 0-1 loss function

$$e_{(y_T,\mathbf{x};\mathbf{w})} = \frac{1}{2} (1 - y_T \ y(\mathbf{x},\mathbf{w}))$$

## Empirical Risk Minimization (ERM)

$$e_{(y_T, \underline{\mathbf{x}}; \underline{\mathbf{w}})} = \frac{1}{2} (1 - y_T \ y(\underline{\mathbf{x}}, \underline{\mathbf{w}}))$$

$$\begin{array}{lcl} E^G_{[\underline{\mathbf{w}}]} & = & \text{probability of misclassification} \\ & = & \int P_{(y_T,\underline{\mathbf{x}})} \, e_{(y_T,\underline{\mathbf{x}};\underline{\mathbf{w}})} \, d\underline{\mathbf{x}} \, dy_T & \stackrel{!}{=} & \min \end{array} \quad \text{(generalization error)}$$

mathematical expectation  $\Downarrow$  ERM  $\Downarrow$   $\longleftarrow$  When does this work? empirical average

$$\begin{split} E_{[\underline{\mathbf{w}}]}^T &= & \text{fraction of misclassifications} \\ &= & \frac{1}{p} \sum_{\alpha=1}^p e_{(y_T^{(\alpha)}, \underline{\mathbf{x}}^{(\alpha)}; \underline{\mathbf{w}})} \stackrel{!}{=} & \min \end{split} \tag{training error}$$

## Change in nomenclature ( $\rightarrow$ Vapnik, 1998)

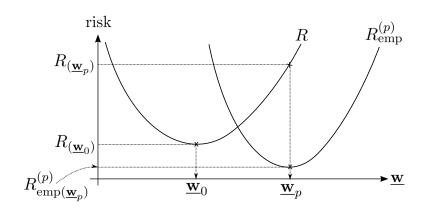
**obability** of misclassification:  $E_{[\mathbf{w}]}^G \to R_{[\mathbf{w}]}$  fraction of misclassification:  $E_{[\mathbf{w}]}^T \to R_{\mathrm{emp}[\mathbf{w}]}$ probability of misclassification: (risk)

(empirical risk)

#### data representation

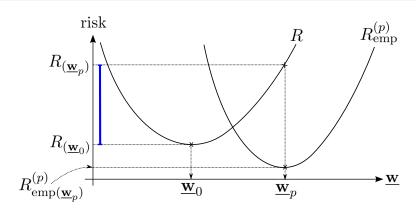
- $\mathbf{p}$  observations  $\mathbf{z}^{(\alpha)} := (\mathbf{x}^{(\alpha)}, y_T^{(\alpha)}), \alpha \in \{1, \dots, p\}$
- observations are drawn i.i.d. from an unknown distribution  $P(\mathbf{x}, y_T) = P(y_T | \mathbf{x}) P(\mathbf{x}).$
- **stationarity:** training and test distributions are identical

## The learning problem



- $\blacksquare$  samples is drawn *i.i.d.* from  $P(\underline{\mathbf{x}}, y_T)$ 
  - $ightharpoonup R_{\sf emp}^{(p)}$  is a random variable
  - $\leadsto$   $\underline{\mathbf{w}}_n$  is a random variable

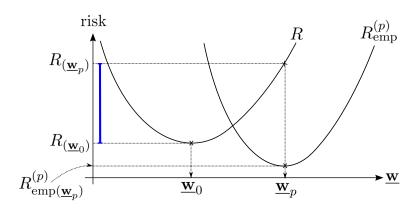
## The key questions of Statistical Learning Theory



- When does inductive learning through ERM work?
  - $\blacksquare$   $R(\underline{\mathbf{w}}_p)$  should reflect the true optimal risk  $R(\underline{\mathbf{w}}_0)$  in the limit  $p \to \infty$ :

$$\lim_{p\to\infty} P\Big\{ |R_{(\underline{\mathbf{w}}_p)} - R_{(\underline{\mathbf{w}}_0)}| \geq \eta \Big\} \ = \ 0 \,, \quad \text{ for all } \quad \eta>0 \,.$$

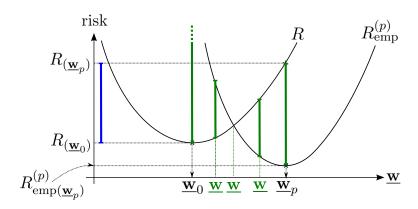
## The key questions of Statistical Learning Theory



- ② How strongly does  $R_{(\underline{\mathbf{w}}_n)}$  differ from  $R_{(\underline{\mathbf{w}}_0)}$  for **finite** samples?
  - $\blacksquare$  For a given confidence  $\epsilon$ , find  $\eta$  such that

$$P\{|R_{(\underline{\mathbf{w}}_n)} - R_{(\underline{\mathbf{w}}_0)}| \ge \eta\} < \epsilon.$$

## The key questions of Statistical Learning Theory



- **3** Do training errors  $R_{\text{emp}(\underline{\mathbf{w}})}$  reflect generalization performance  $R_{(\underline{\mathbf{w}})}$ ?
  - lacktriangleright Avoid overfitting for finite samples, i.e. given confidence  $\epsilon$ , find  $\eta$  such that:

$$P \Big\{ \big| R_{(\underline{\mathbf{w}})} - R_{\mathrm{emp}(\underline{\mathbf{w}})} \big| > \eta \Big\} \ < \ \epsilon \,, \qquad \forall \underline{\mathbf{w}} \in \Lambda \,.$$

# 2.1.3 General Classifiers: Conditions for Inductive Learning

## Conditions for successful learning with ERM

The success of ERM depends on...

- lacktriangle the model class (o set of classifiers)
- lacktriangle the availability of data (o growth function)

## Conditions for successful learning with ERM

The success of ERM depends on...

- $\blacksquare$  the model class ( $\rightarrow$  set of classifiers)
- the availability of data ( $\rightarrow$  growth function)

Key concepts: growth function & capacity measures (VC-dimension)

#### results (milestones)

- asymptotic result: learning success for a potentially infinite number of training data
- ginite samples: deviation of the generalization error from the generalization error of the optimal model
- Inite samples: bound on the generalization error for every model

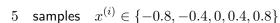
for technical details, conditions for non-trivial consistency etc. see Vapnik (1998)

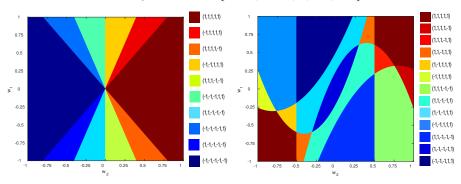
## The growth function $G_{(p)}^{\Lambda}$

- data representation:  $\underline{\mathbf{x}} \in \mathbb{R}^N$ ,  $y_T \in \{-1, +1\}$
- model class: set  $\Lambda$  of functions  $y_{(\mathbf{x};\mathbf{w})} \in \{-1,+1\}$
- $\blacksquare \ \, \text{binary label vector:} \ \underline{\mathbf{y}}_{(\underline{\mathbf{w}})} = \left(y_{(\underline{\mathbf{x}}^{(1)},\underline{\mathbf{w}})},y_{(\underline{\mathbf{x}}^{(2)},\underline{\mathbf{w}})},\dots,y_{(\underline{\mathbf{x}}^{(p)},\underline{\mathbf{w}})}\right)$ 
  - different classifiers can induce the same label vector on the training set
- $\blacksquare$  number of different vectors  $\underline{\mathbf{y}}_{(\mathbf{w})}$  induced by all  $\hat{y} \in \Lambda$ :

$$N^{\Lambda}_{(\mathbf{x}^{(1)},\dots,\mathbf{x}^{(p)})}$$
  $\leq 2^p$  (depends on  $\Lambda$  and the samples)

## The growth function $G^{\Lambda}_{(p)}$





$$f(x|\underline{\mathbf{w}}) = \operatorname{sign}\left(w_1 x + w_2\right)$$

$$f(x|\underline{\mathbf{w}}) = \operatorname{sign}\left(w_1 x + w_2\right)$$
  $f(x|\underline{\mathbf{w}}) = \operatorname{sign}\left(w_1 x + (x - w_2)^2 - \frac{1}{4}\right)$ 

$$N^{\Lambda}_{(x^{(1)},\dots,x^{(5)})} = 10 \le 2^5$$

$$N^{\Lambda}_{(x^{(1)},\dots,x^{(5)})} = 13 \le 2^5$$

## The growth function $G_{(p)}^{\Lambda}$

$$G_{(p)}^{\Lambda} = \ln \left( \sup_{\underline{\mathbf{x}}^{(1)}, \dots, \underline{\mathbf{x}}^{(p)}} N_{(\underline{\mathbf{x}}^{(1)}, \dots, \underline{\mathbf{x}}^{(p)})}^{\Lambda} \right)$$
worst case

## The growth function $G_{(p)}^{\Lambda}$

$$G_{(p)}^{\Lambda} = \ln \underbrace{\left(\sup_{\underline{\mathbf{x}}^{(1)}, \dots, \underline{\mathbf{x}}^{(p)}} N_{(\underline{\mathbf{x}}^{(1)}, \dots, \underline{\mathbf{x}}^{(p)})}^{\Lambda}\right)}_{\text{worst case}}$$

bound on growth function (Vapnik, 1998)

$$G_{(p)}^{\Lambda} \left\{ \begin{array}{ll} = p \ln 2 & \text{for } p \leq \mathrm{d_{VC}} \\ \leq \mathrm{d_{VC}} \Big( 1 + \ln \frac{p}{\mathrm{d_{VC}}} \Big) & \text{for } p > \mathrm{d_{VC}} \end{array} \right.$$

## The growth function $G^{\Lambda}_{(p)}$

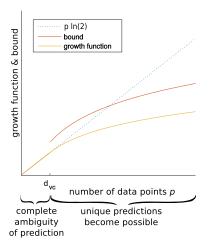
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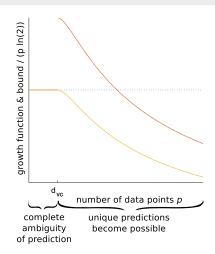
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■ Vapnik-Chernovenkis dimension  $d_{VC}$ : capacity measure of the model class

# The growth function $G^{\Lambda}_{(p)}$





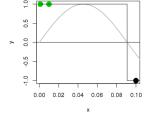
- $lacktriangledown d_{VC}$ : capacity measure of the model class
  - lacktriangleright small  $d_{VC}$ : small sample size sufficient for learning
  - large  $d_{VC}$ : large sample size required

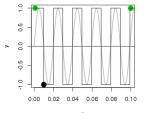
### The Vapnik-Chervonenkis dimension

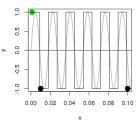
- $\blacksquare$   $d_{VC}$  is ...
  - lacktriangleright largest number of data points on which (at least for one set)  $2^p$  different loss vectors (i.e. label assignments) can be induced
  - capacity measure for a given set of models
  - purely combinatorial concept (worst case scenario)
  - provides a bound on the growth function ...
  - lacksquare ...  $\leadsto$  determines the number of samples needed to reliably learn
- lacktriangle  $\mathrm{d}_{\mathrm{VC}}$  is typically hard to compute
  - bounds have been derived for some architectures
  - e.g. MLPs with sigmoidal units:  $d_{VC} = \mathcal{O}(W^2)$ , where W is number of parameters, Koiran and Sontag (1996)

### An unlearnable problem

- set of classifiers:  $\hat{y}(x; a) = \text{sign}[\sin(ax)]$ , single model parameter a
- selection of classifiers (cf. Vapnik, 1998)
  - take  $x_i = 10^{-i}, i = 1, ..., N$  and assign any  $y_i \in \{-1, +1\}$
  - $\blacksquare$  set  $a = \pi (1 + \sum_{i=1}^{N} \frac{(1 y_i)10^i}{2})$

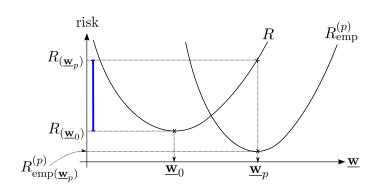






lacksquare a single model parameter, but an infinite  $d_{VC}$ 

### The learning problem and its solution (1)

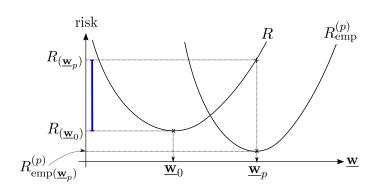


learnability: asymptotic result

$$\mathrm{d}_{\mathrm{VC}} \; \mathrm{finite} \quad \Rightarrow \quad \lim_{p \to \infty} P \bigg\{ \Big| R_{(\underline{\mathbf{w}}_p)} - R_{(\underline{\mathbf{w}}_0)} \Big| \ge \eta \bigg\} \quad = \quad 0 \,, \quad \forall \eta > 0$$

 $\blacksquare$  convergence of ERM is only guaranteed if  $d_{VC}$  is finite

### The learning problem and its solution (2)

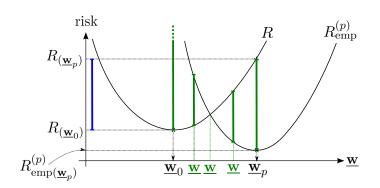


finite samples: deviation from the optimal model

$$P\bigg\{R_{(\underline{\mathbf{w}}_p)} - R_{(\underline{\mathbf{w}}_0)} > \Big(\frac{G_{(2p)}^{\Lambda} - \ln\frac{\epsilon}{8}}{p}\Big)^{\frac{1}{2}} + \Big(-\frac{\ln\frac{\epsilon}{2}}{2p}\Big)^{\frac{1}{2}} + \frac{1}{p}\bigg\} < \epsilon$$

lacksquare finite  $d_{VC}$ : increased sample size  $p \Rightarrow$  reduction of the bound

### The learning problem and its solution (3)



§ finite samples: bound on the generalization error

$$P\bigg\{\sup_{\mathbf{w}\in\Lambda}\Big|R_{(\underline{\mathbf{w}})}-R_{\mathsf{emp}(\underline{\mathbf{w}})}^{(p)}\Big|>\eta\bigg\}<4\exp\Big(G_{(2p)}^{\Lambda}-p\big(\eta-\frac{1}{p}\big)^2\Big)$$

 $\blacksquare$  bound non-trivial only if  $G^{\Lambda}_{(2p)}$  is sub-linear in p

(see blackboard)

### Regression problems

regression problems can be treated in a similar manner

## End of Section 2.1

the following slides contain

# OPTIONAL MATERIAL

### Mathematical preliminaries

#### binomial Coefficient

$$\begin{pmatrix} n \\ k \end{pmatrix} = \left\{ \begin{array}{ll} \frac{n!}{k!(n-k)!}, & n \ge k \\ 0, & \text{else} \end{array} \right.$$

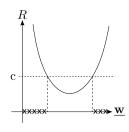
#### binomial distribution

$$f(k; n, p) = \binom{n}{k} p^k (1-p)^{n-k}$$

#### cumulative distribution

$$F(k;n,p) = Pr(X \le k) = \sum_{x=0}^{k} f(x;n,p)$$

### Strict Consistency

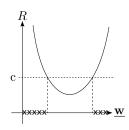


 $\begin{array}{ll} \Lambda = \{\underline{\mathbf{w}}\}: & \text{set of all predictors} \\ \Lambda_{(c)} \subset \Lambda: & \text{set of all "bad" predictors} \end{array}$ 

 $\times\times\times$ :

 $\Lambda_{(c)} = \{ \underline{\mathbf{w}} : R_{(\mathbf{w})} \ge c \}$ 

### Strict Consistency



$$\Lambda = \{ \underline{\mathbf{w}} \}$$
 : set of all predictors

$$\Lambda = \{\underline{\mathbf{w}}\}: \quad \text{set of all predictors} \\ \Lambda_{(c)} \subset \Lambda: \quad \text{set of all "bad" predictors}$$

$$\times \times \times$$
 :

$$\times \times \times : \qquad \Lambda_{(c)} = \{ \underline{\mathbf{w}} : R_{(\underline{\mathbf{w}})} \ge c \}$$

#### definition and implications of strict consistency

$$\lim_{p \to \infty} P \left\{ \left| \inf_{\underline{\mathbf{w}} \in \Lambda_{(c)}} R_{\text{emp}(\underline{\mathbf{w}})}^{(p)} - \inf_{\underline{\mathbf{w}} \in \Lambda_{(c)}} R_{(\underline{\mathbf{w}})} \right| \ge \eta \right\} = 0$$

strict consistency  $\stackrel{\rightarrow}{\leftarrow}$  inductive learning via ERM

proof: supplementary material

### Strict Consistency → convergence in the limit

#### key theorem of learning theory

let  $a \leq R_{(\mathbf{w})} \leq A$  for all  $\underline{\mathbf{w}} \in \Lambda$  and  $P_{(\mathbf{z})} \in \Pi$ , then:

the ERM procedure is strictly consistent for  $\Lambda$  and  $\Pi$ 

$$\lim_{p\to\infty} P \bigg\{ \sup_{\mathbf{w}\in\Lambda} \Big( R_{(\underline{\mathbf{w}})} - R_{\mathrm{emp}(\underline{\mathbf{w}})}^{(p)} \Big) > \eta \bigg\} = 0 \,, \quad \text{ for all } \quad P_{(\underline{\mathbf{z}})} \in \Pi \,.$$

proof: supplementary material

 $\blacksquare$  uniform (one-sided) convergence of  $R_{\rm emp(w)}^{(p)}$  to  $R_{(\underline{\bf w})}$  for  $p\to\infty$